

Structural Characterization of Broad Oxide Layers of Ag Single Crystals Caused by Hyperthermal Atomic Oxygen by SEM and TEM

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Hyperthermal atomic oxygen (AO) is the major species in the Low Earth Orbit (LEO), defined as approximately 200 to 500 miles above the earth, hastening failure to materials exposed in this harsh environment [1]. Silver is used in a wide variety of applications in LEO, such as electron conductive material [2] as well as a detector or sensor material for calibrating atomic oxygen exposure [3-5]. We focused on the morphology changes on a model metal material, Ag, when exposed to hyperthermal atomic oxygen in order to gain insights into degradation mechanisms in Low Earth Orbit.

We exposed both Ag(100) and Ag(111) single crystals to an atomic oxygen source with 50,000 shots at 220 °C simultaneously, where the 5eV atomic oxygen was created by the detonation of oxygen gas with a pulsed laser. The oxide surfaces were protected by gluing a silicon wafer on each to prepare samples for observations of cross-section SEM (XSEM) and cross-section TEM (XTEM). SEM images reveal the morphology of AO oxidation of Ag(100) and Ag(111) with very rough surfaces on Figure 1 (a) and (b), with mud-like cracks on Ag(100) and cracks on Ag(111), respectively. Figures 1 (c) and (d) are XSEM images of oxide layers of Ag(100) and Ag(111), which reveal a very thick oxide scale with multiple oxide layers containing elongated, large pores. The Ag(100) oxide scale has an average thickness of 11.6 microns and the Ag(111) oxide scale forms a thicker oxide scale of 14.9 microns. The detached oxide from the Ag demonstrates a very weak bond between crystal silver substrate and its oxide film. Figures 2 (a) and (b) are XTEM images of Ag (100) oxide layer. Figure 2(a) shows the broad intact interface of Ag(100) and the oxide layer. The inset electron diffraction pattern (EDP) shows a single crystalline silver of the substrate and a complex poly-crystalline oxide layer. Figure 2(b) reveals the complex microstructures of the oxide layer, such as porosity, micro-twins and irregular shaped grains. The inset EDP shows the polycrystalline structure of oxide layer. Figure 2 (c) is a XTEM image of Ag(111) oxide layer, showing the broad and detached interface. Figure 2(d) is high-mag TEM image of the interface of Ag(111) and the oxide layer, showing the nano-crystallites of oxides in 10~40nm near interface area.

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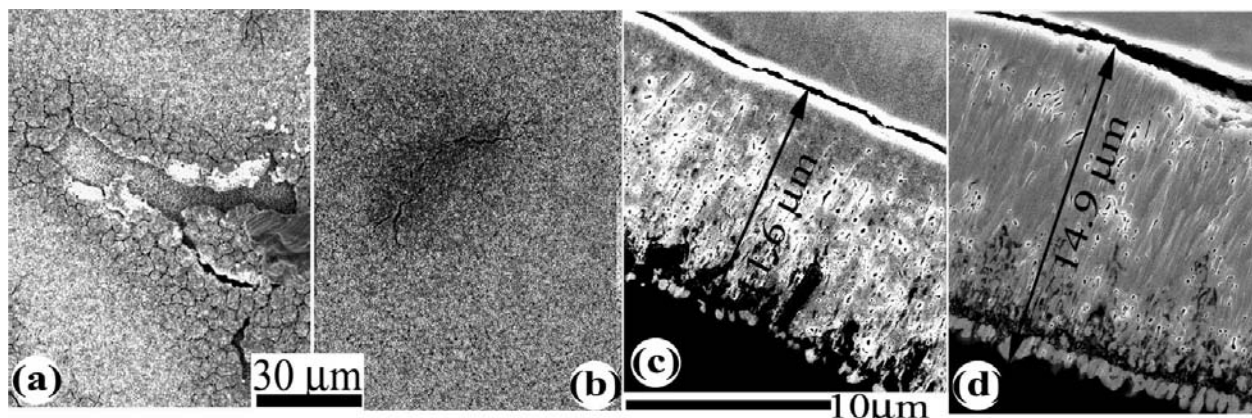


Figure 1. SEM images of: (a) oxide scale of Ag(100), (b) oxide scale of Ag(111), (c) cross-section of Ag(100) and (d) cross-section of Ag(111), respectively.

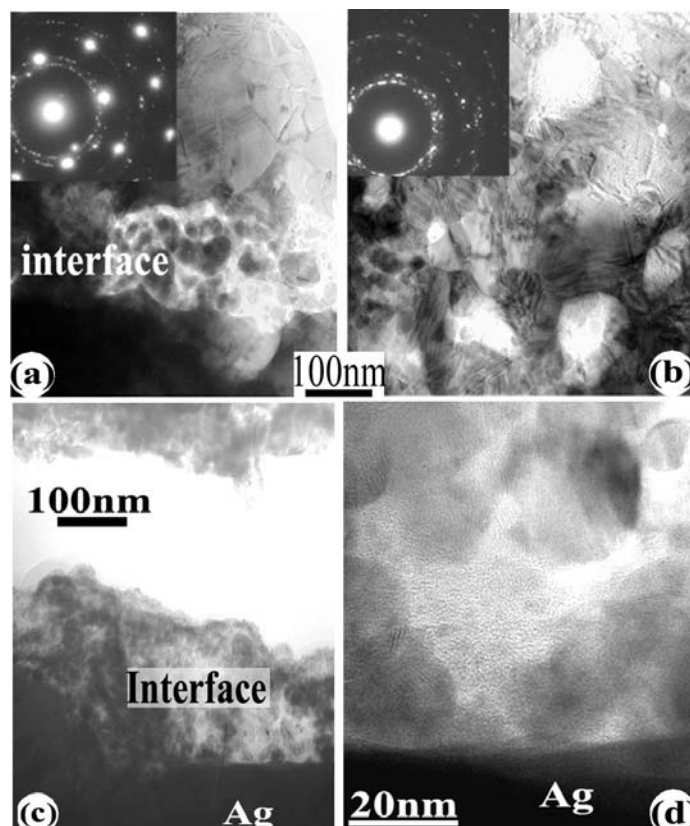


Figure 2. Cross-section TEM images: (a) broad intact interface and (b) the oxide scale of Ag(100) oxide layer, both with inset corresponding EDP, (c) broad, detached interface of Ag(111) oxide layer, and (d) high-magnification image of Ag(111) interface, showing silver oxide crystallites at interface area.